

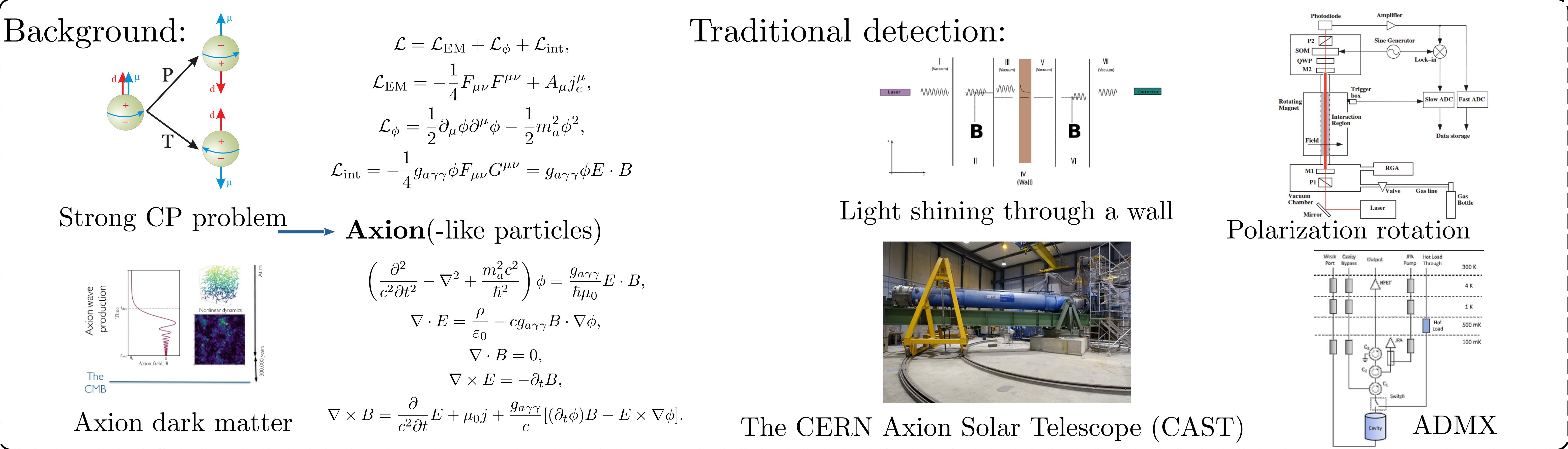
#4 Modeling of axion and electromagnetic fields interaction in particle-in-cell simulations

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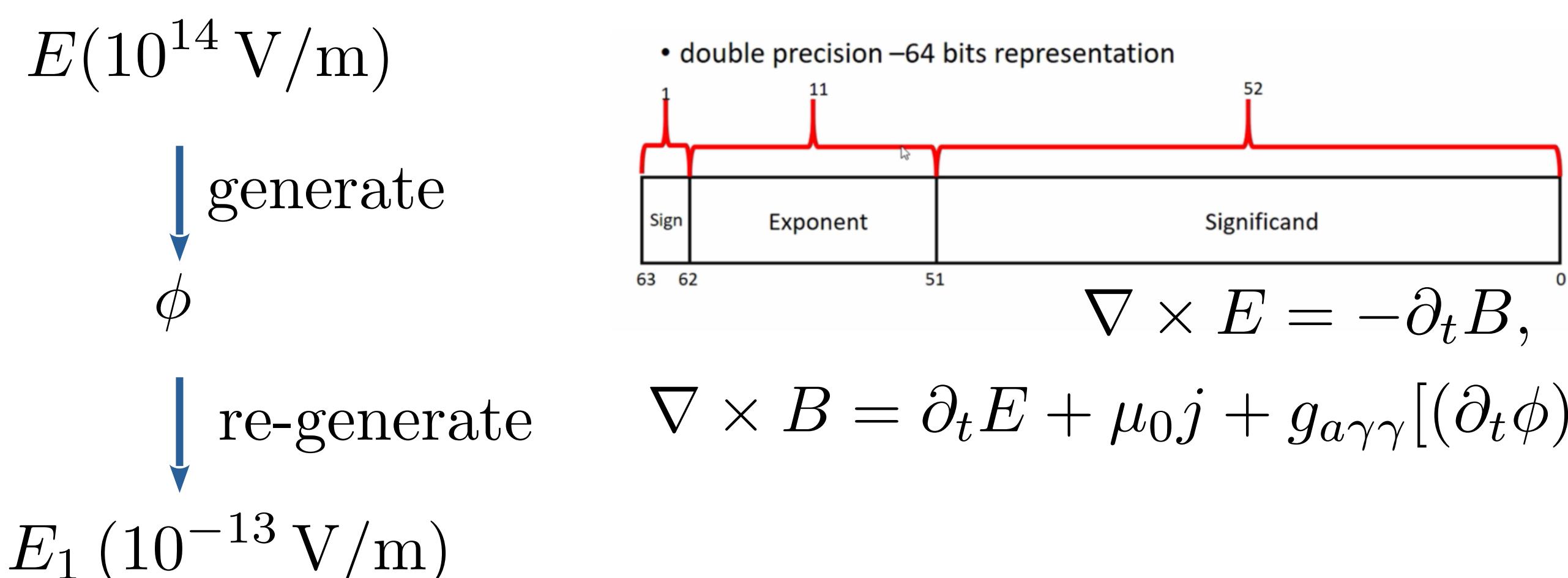
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Necessity of field perturbation separation (FPS)



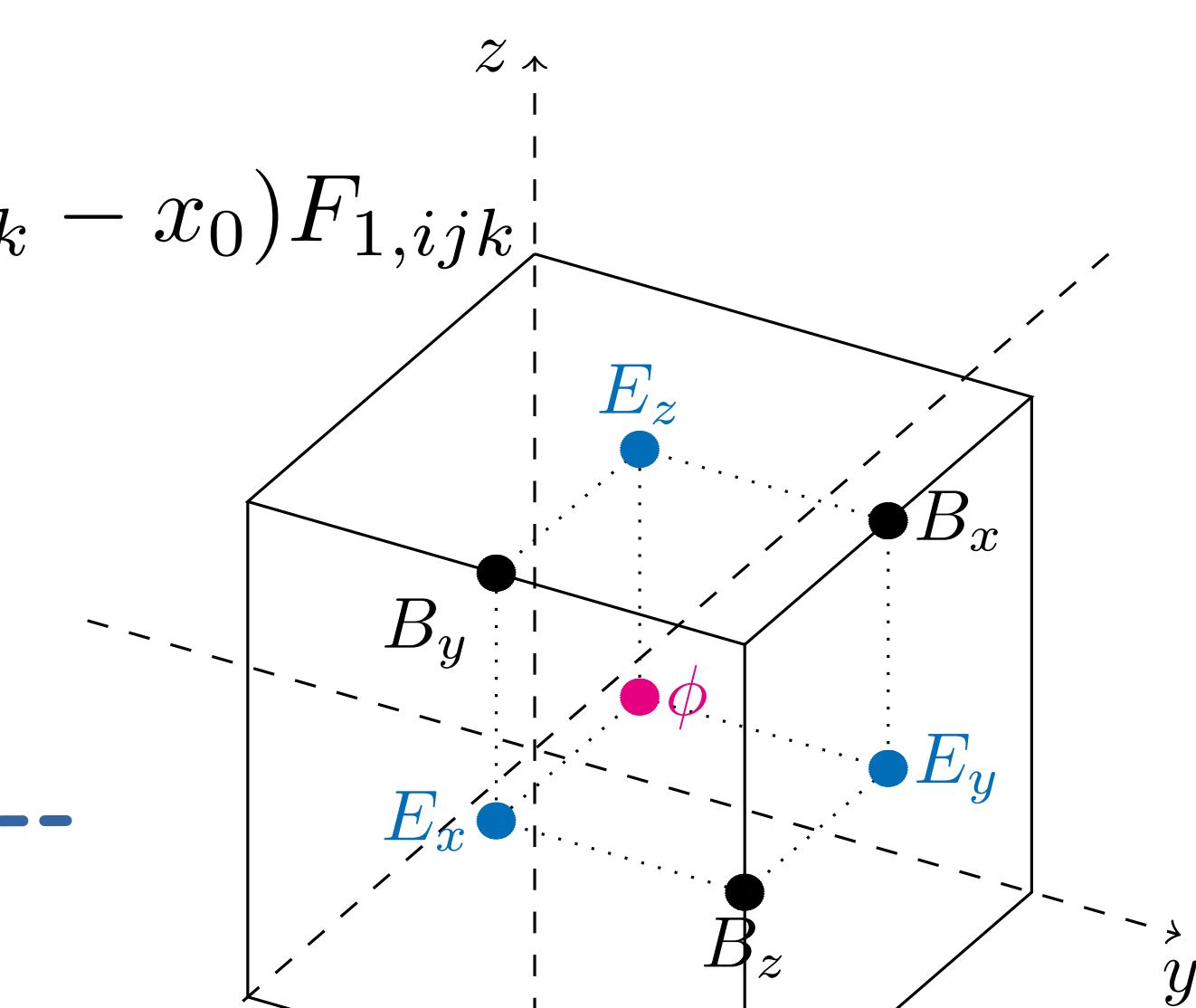
$E_0 \& E_1$ in the code

$$\begin{aligned} \nabla \times E_0 &= -\partial_t B_0, \\ \nabla \times B_0 &= \partial_t E_0 + \mu_0 j_0. \\ \nabla \times E_1 &= -\partial_t B_1, \\ \nabla \times B_1 &= \partial_t E_1 + \mu_0 j_1 + g_{a\gamma\gamma}[(\partial_t \phi) B_0 - E_0 \times \nabla \phi]. \end{aligned}$$

Perturbation on the particle motion

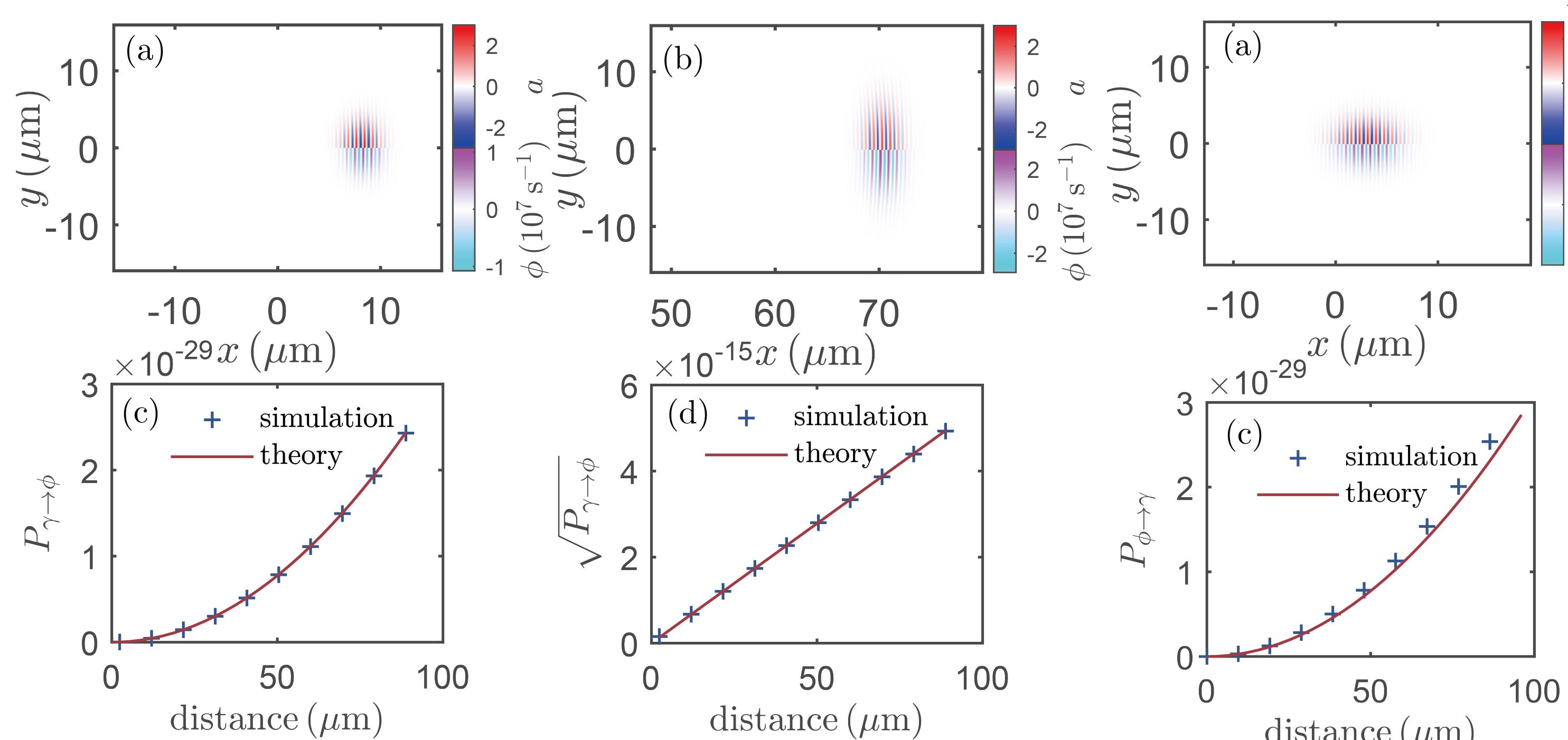
$$\frac{dx_1}{dt} = v_1, \quad \frac{dp_1}{dt} = q(E_p + v_0 \times B_p + v_1 \times B_{nop}), \quad v_1 = \frac{\partial v}{\partial p} \cdot p_1 = \frac{c}{\gamma_0^3} [\gamma_0^2 u_1 - u_0 (u_0 \cdot u_1)],$$

$$\begin{aligned} F|_{x=x_0+x_1} &= (F_0 + F_1)|_{x=x_0+x_1} \approx \sum_{ijk} S(r_{ijk} - x_0) F_{0,ijk} + \sum_{ijk} \left[\frac{\partial S(r_{ijk} - x)}{\partial x} \Big|_{x=x_0} \cdot x_1 \right] F_{0,ijk} + \sum_{ijk} S(r_{ijk} - x_0) F_{1,ijk} \\ (j_0 + j_1)_{ijk} &= \frac{q}{\Delta V} [S(r_{ijk} - x_0 - x_1) (v_0 + v_1)] \approx \frac{q}{\Delta V} S(r_{ijk} - x_0) v_0 + \frac{q}{\Delta V} \left[\frac{\partial S(r_{ijk} - x)}{\partial x} \Big|_{x=x_0} \cdot x_1 \right] v_0. \end{aligned}$$



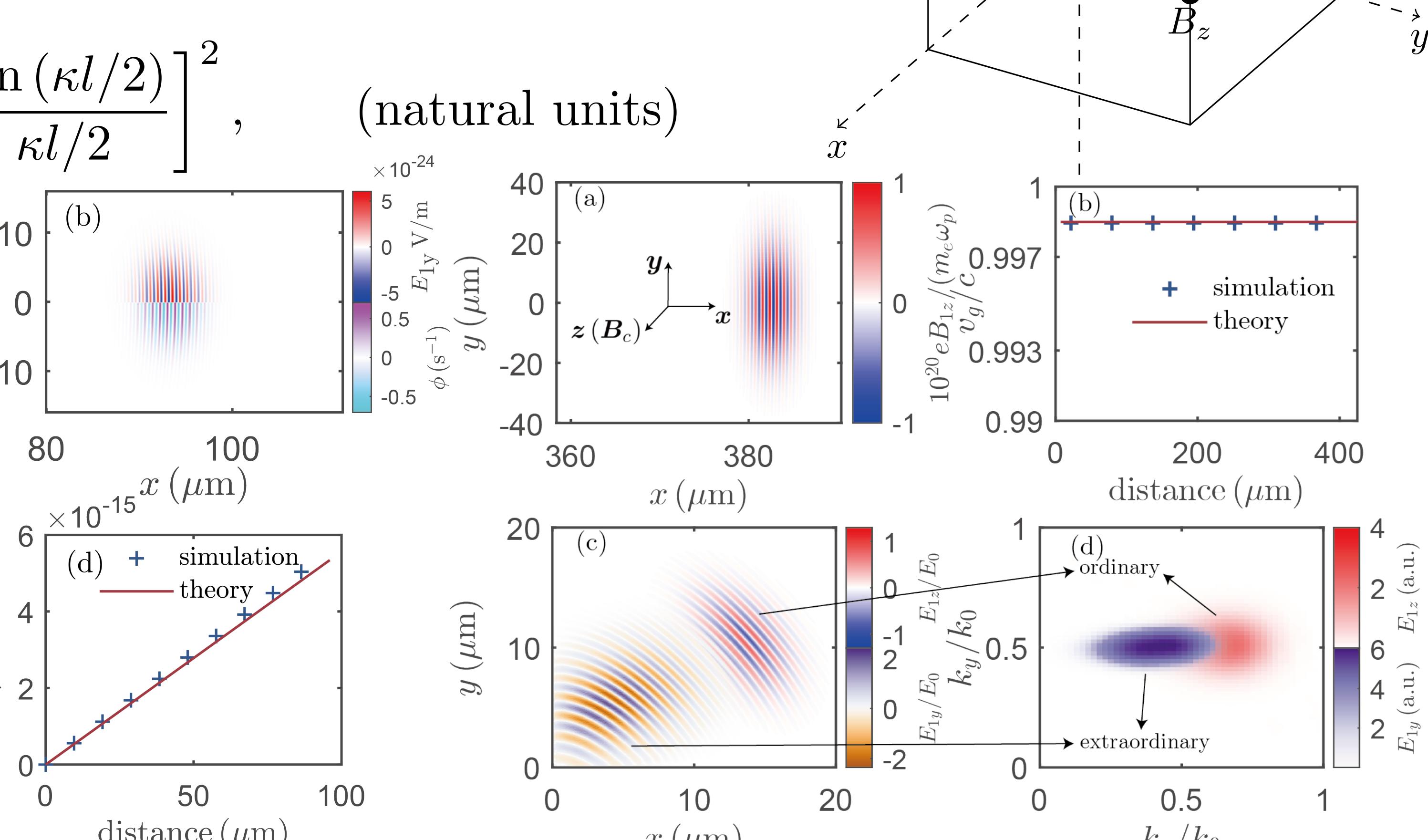
Benchmarks:

In a constant magnetic field: $P_{\gamma \rightarrow \phi} = P_{\phi \rightarrow \gamma} \approx \frac{1}{4} (g_{a\gamma\gamma} B_0 l)^2 \left[\frac{\sin(\kappa l/2)}{\kappa l/2} \right]^2$, (natural units)



Axion generation

Axion conversion



FPS model (birefringence)
Weak laser in strong background

Summary:

- 1) Model the axion field and its interaction with EM field in the PIC code.
- 2) Use the FPS model to handle the weak modulation of axion on EM fields.
- 3) Benchmark of the axion generation, conversion, and FPS model.



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